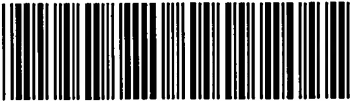


Search Notes 	Application/Control No. 10734472	Applicant(s)/Patent Under Reexamination CHARETTE, MARC F.
	Examiner Wang, Chang-Yu	Art Unit 1649

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
sequence search: SEQ ID NO:2 and aa. 30-431, aa. 30-292, 292-330, 292-431 of SEQ ID NO:21. See sequence search results in SCORE (Jan 5, 2006) (updated)	6/8/07	CYW
EAST, STN: search strategy attached (updated)	6/8/07	CYW
Inventor name search: EAST, STN, PALM (updated)	6/8/07	CYW
PLUS search from STIC. See search results in eDAN (4/16/07)	4/16/07	CYW

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner